ELPIDA

DATA SHEET

256MB Direct Rambus™ DRAM RIMM™ Module

EBR25EC8ABFD (128M words × 18 bits)

Description

The Direct Rambus RIMM module is a general-purpose high-performance memory module subsystem suitable for use in a broad range of applications including computer memory, personal computers, workstations, and other applications where high bandwidth and low latency are required.

The EBR25EC8ABFD consists of 8 pieces of 288M Direct Rambus DRAM (Direct RDRAM™) devices. These are extremely high-speed CMOS DRAMs organized as 16M words by 18 bits. The use of Rambus Signaling Level (RSL) technology permits 1066MHz or 800MHz transfer rates while using conventional system and board design technologies.

The architecture of the Direct RDRAM enables the highest sustained bandwidth for multiple, simultaneous, randomly addressed memory transactions.

The separate control and data buses with independent row and column control yield over 95% bus efficiency. The Direct RDRAM device's 32 banks support up to four simultaneous transactions per device.

Features

- 256MB Direct RDRAM storage and 256 banks total on module
- High speed 1066MHz/800MHz Direct RDRAM devices
- 184 edge connector pads with 1mm pad spacing
  - Module PCB size: 133.35mm × 34.925mm × 1.27mm
  - Gold plated edge connector pads contacts
- Serial Presence Detect (SPD) support
- Operates from a 2.5V supply
- Low power and power down self refresh modes
- Separate Row and Column buses for higher efficiency
- RDRAM®devices use Chip Scale Package (CSP)
  - FBGA package

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Ordering Information

Part number	Organization	I/O Freq. (MHz)	RAS access time (ns)	Package	Mounted devices
EBR25EC8ABFD-AEP	128M x 18	1066	32 (32P)	184 edge connector pads RIMM with heat spreader	EDR2518ABSE
EBR25EC8ABFD-AE			32	Edge connector: Gold plated	
EBR25EC8ABFD-AD			35		
EBR25EC8ABFD-8C		800	40		

Module Pad Names

Pad	Signal Name	Pad	Signal Name	Pad	Signal Name	Pad	Signal Name
A1	GND	B1	GND	A47	NC	B47	NC
A2	LDQA8	B2	LDQA7	A48	NC	B48	NC
A3	GND	B3	GND	A49	NC	B49	NC
A4	LDQA6	B4	LDQA5	A50	NC	B50	NC
A5	GND	B5	GND	A51	VREF	B51	VREF
A6	LDQA4	B6	LDQA3	A52	GND	B52	GND
A7	GND	B7	GND	A53	SCL	B53	SA0
A8	LDQA2	B8	LDQA1	A54	VDD	B54	VDD
A9	GND	B9	GND	A55	SDA	B55	SA1
A10	LDQA0	B10	LCFM	A56	SVDD	B56	SVDD
A11	GND	B11	GND	A57	SWP	B57	SA2
A12	LCTMN	B12	LCFMN	A58	VDD	B58	VDD
A13	GND	B13	GND	A59	RSCK	B59	RCMD
A14	LCTM	B14	NC	A60	GND	B60	GND
A15	GND	B15	GND	A61	RDQB7	B61	RDQB8
A16	NC	B16	LROW2	A62	GND	B62	GND
A17	GND	B17	GND	A63	RDQB5	B63	RDQB6
A18	LROW1	B18	LROW0	A64	GND	B64	GND
A19	GND	B19	GND	A65	RDQB3	B65	RDQB4
A20	LCOL4	B20	LCOL3	A66	GND	B66	GND
A21	GND	B21	GND	A67	RDQB1	B67	RDQB2
A22	LCOL2	B22	LCOL1	A68	GND	B68	GND
A23	GND	B23	GND	A69	RCOL0	B69	RDQB0
A24	LCOL0	B24	LDQB0	A70	GND	B70	GND
A25	GND	B25	GND	A71	RCOL2	B71	RCOL1
A26	LDQB1	B26	LDQB2	A72	GND	B72	GND
A27	GND	B27	GND	A73	RCOL4	B73	RCOL3
A28	LDQB3	B28	LDQB4	A74	GND	B74	GND
A29	GND	B29	GND	A75	RROW1	B75	RROW0
A30	LDQB5	B30	LDQB6	A76	GND	B76	GND
A31	GND	B31	GND	A77	NC	B77	RROW2
A32	LDQB7	B32	LDQB8	A78	GND	B78	GND
A33	GND	B33	GND	A79	RCTM	B79	NC
A34	LSCK	B34	LCMD	A80	GND	B80	GND

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Pad	Signal Name	Pad	Signal Name
A35	VCMOS	B35	VCMOS
A36	SOUT	B36	SIN
A37	VCMOS	B37	VCMOS
A38	NC	B38	NC
A39	GND	B39	GND
A40	NC	B40	NC
A41	VDD	B41	VDD
A42	VDD	B42	VDD
A43	NC	B43	NC
A44	NC	B44	NC
A45	NC	B45	NC
A46	NC	B46	NC

Pad	Signal Name	Pad	Signal Name
A81	RCTMN	B81	RCFMN
A82	GND	B82	GND
A83	RDQA0	B83	RCFM
A84	GND	B84	GND
A85	RDQA2	B85	RDQA1
A86	GND	B86	GND
A87	RDQA4	B87	RDQA3
A88	GND	B88	GND
A89	RDQA6	B89	RDQA5
A90	GND	B90	GND
A91	RDQA8	B91	RDQA7
A92	GND	B92	GND

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Module Connector Pad Description

Signal	Module Connector Pads	I/O	Type	Description
GND	A1, A3, A5, A7, A9, A11, A13, A15, A17, A19, A21, A23, A25, A27, A29, A31, A33, A39, A52, A60, A62, A64, A66, A68, A70, A72, A74, A76, A78, A80, A82, A84, A86, A88, A90, A92, B1, B3, B5, B7, B9, B11, B13, B15, B17, B19, B21, B23, B25, B27, B29, B31, B33, B39, B52, B60, B62, B64, B66, B68, B70, B72, B74, B76, B78, B80, B82, B84, B86, B88, B90, B92	—	—	Ground reference for RDRAM core and interface. 72 PCB connector pads.
LCFM	B10	I	RSL	Clock from master. Interface clock used for receiving RSL signals from the Channel. Positive polarity.
LCFMN	B12	I	RSL	Clock from master. Interface clock used for receiving RSL signals from the Channel. Negative polarity.
LCMD	B34	I	VCMOS	Serial Command used to read from and write to the control registers. Also used for power management.
LCOL4..LCOL0	A20, B20, A22, B22, A24	I	RSL	Column bus. 5-bit bus containing control and address information for column accesses.
LCTM	A14	I	RSL	Clock to master. Interface clock used for transmitting RSL signals to the Channel. Positive polarity.
LCTMN	A12	I	RSL	Clock to master. Interface clock used for transmitting RSL signals to the Channel. Negative polarity.
LDQA8..LDQA0	A2, B2,A4, B4, A6, B6, A8, B8, A10	I/O	RSL	Data bus A. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM.
LDQB8..LDQB0	B32, A32, B30, A30, B28, A28, B26, A26, B24	I/O	RSL	Data bus B. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM.
LROW2..LROW0	B16, A18, B18	I	RSL	Row bus. 3-bit bus containing control and address information for row accesses.
LSCK	A34	I	VCMOS	Serial clock input. Clock source used to read from and write to the RDRAM control registers.
NC	A16, B14, A38, B38, A40, B40, A77, B79, A43, B43, A44, B44, A45, B45, A46, B46, A47, B47, A48, B48, A49, B49, A50, B50	—	—	These pads are not connected. These 24 connector pads are reserved for future use.
RCFM	B83	I	RSL	Clock from master. Interface clock used for receiving RSL signals from the Channel. Positive polarity.
RCFMN	B81	I	RSL	Clock from master. Interface clock used for receiving RSL signals from the Channel. Negative polarity.
RCMD	B59	I	VCMOS	Serial Command Input used to read from and write to the control registers. Also used for power management.
RCOL4..RCOL0	A73, B73, A71, B71, A69	I	RSL	Column bus. 5-bit bus containing control and address information for column accesses.
RCTM	A79	I	RSL	Clock to master. Interface clock used for transmitting RSL signals to the Channel. Positive polarity.
RCTMN	A81	I	RSL	Clock to master. Interface clock used for transmitting RSL signals to the Channel. Negative polarity.
RDQA8..RDQA0	A91, B91, A89, B89, A87, B87, A85, B85, A83	I/O	RSL	Data bus A. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM.
RDQB8..RDQB0	B61, A61, B63, A63, B65, A65, B67, A67, B69	I/O	RSL	Data bus B. A 9-bit bus carrying a byte of read or write data between the Channel and the RDRAM.
RROW2..RROW0	B77, A75, B75	I	RSL	Row bus. 3-bit bus containing control and address information for row accesses.

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Signal	Module Connector Pads	I/O	Type	Description
RSCK	A59	I	VCMOS	Serial clock input. Clock source used to read from and write to the RDRAM control registers.
SA0	B53	I	SVDD	Serial Presence Detect Address 0.
SA1	B55	I	SVDD	Serial Presence Detect Address 1.
SA2	B57	I	SVDD	Serial Presence Detect Address 2.
SCL	A53	I	SVDD	Serial Presence Detect Clock.
SDA	A55	I/O	SVDD	Serial Presence Detect Data (Open Collector I/O).
SIN	B36	I/O	VCMOS	Serial I/O for reading from and writing to the control registers. Attaches to SIO0 of the first RDRAM on the module.
SOUT	A36	I/O	VCMOS	Serial I/O for reading from and writing to the control registers. Attaches to SIO1 of the last RDRAM on the module.
SVDD	A56, B56	—	—	SPD Voltage. Used for signals SCL, SDA, SWP, SA0, SA1 and SA2.
SWP	A57	I	SVDD	Serial Presence Detect Write Protect (active high). When low, the SPD can be written as well as read.
VCMOS	A35, B35, A37, B37	—	—	CMOS I/O Voltage. Used for signals CMD, SCK, SIN, SOUT.
VDD	A41, A42, A54, A58, B41, B42, B54, B58	—	—	Supply voltage for the RDRAM core and interface logic.
VREF	A51, B51	—	—	Logic threshold reference voltage for RSL signals.

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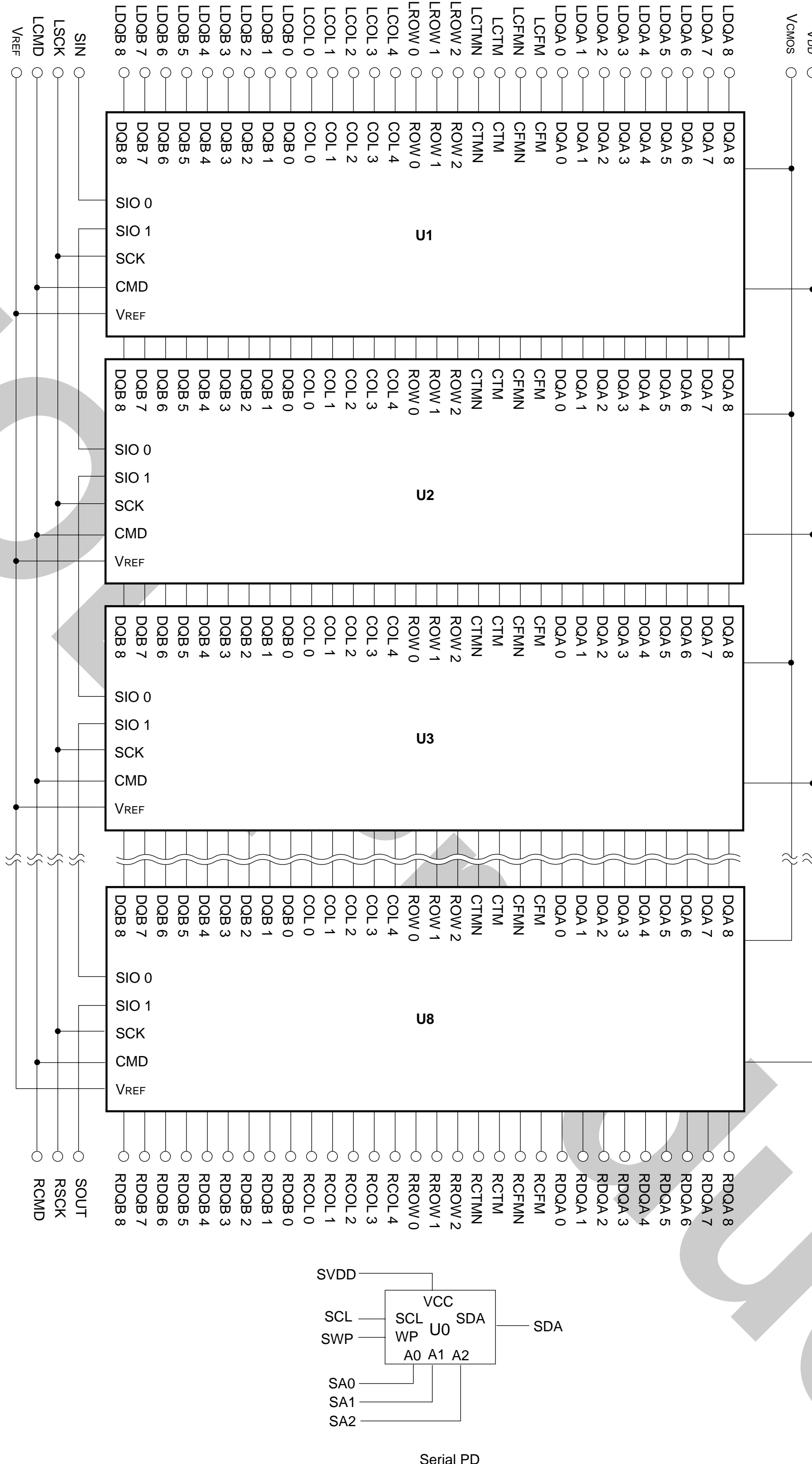
Block Diagram



Serial PD

Note: 1. Rambus Channel signals form a loop through the RIMM module, with the exception of the SIO chain.
2. See Serial Presence Detection Specification for information on the SPD device and its contents.

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Electrical Specifications

Absolute Maximum Ratings

Symbol	Parameter	min.	max.	Unit
VI,ABS	Voltage applied to any RSL or CMOS signal pad with respect to GND	–0.3	VDD + 0.3	V
VDD,ABS	Voltage on VDD with respect to GND	–0.5	VDD + 1.0	V
TSTORE	Storage temperature	–50	+100	°C

Caution

Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

DC Recommended Electrical Conditions

Symbol	Parameter and conditions	min.	max.	Unit
VDD	Supply voltage*[1]	2.50 – 0.13	2.50 + 0.13	V
VCMOS	CMOS I/O power supply at pad 2.5V controllers	2.50 – 0.13	2.50 + 0.25	V
	1.8V controllers	1.8 – 0.1	1.8 + 0.2	V
VREF	Reference voltage*[1]	1.4 – 0.2	1.4 + 0.2	V
SVDD	Serial Presence Detector- positive power supply	2.2	3.6	V

Note: See Direct RDRAM datasheet for more details.

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AC Electrical Specifications

Symbol	Parameter and Conditions	Grade	min.	typ.	max.	Unit
Z	Module Impedance of RSL signals		25.2	28.0	30.8	Ω
	Module Impedance of SCK and CMD signals		23.8	28.0	32.2	Ω
TPD	Average clock delay from finger to finger of all RSL clock nets (CTM, CTMN,CFM, and CFMN)		—	—	1.56	ns
∆TPD	Propagation delay variation of RSL signals with respect to TPD *[1, 2]		-21	—	21	ps
∆TPD-CMOS	Propagation delay variation of SCK signal with respect to an average clock delay *[1]		-250	—	250	ps
∆TPD- SCK,CMD	Propagation delay variation of CMD signal with respect to SCK signal		-200	—	200	ps
Vα/VIN	Attenuation Limit	-AEP -AE -AD -8C	—	—	17.0	%
VXF/VIN	Forward crosstalk coefficient (300ps input rise time 20% - 80%)	-AEP -AE -AD -8C	—	—	4.0	%
VXB/VIN	Backward crosstalk coefficient (300ps input rise time 20% - 80%)	-AEP -AE -AD -8C	—	—	2.0	%
RDC	DC Resistance Limit	-AEP -AE -AD -8C	—	—	0.8	Ω

Notes 1. TPD or Average clock delay is defined as the average delay from finger to finger of all RSL clock nets (CTM, CTMN, CFM, and CFMN).

2. If the RIMM module meets the following specification, then it is compliant to the specification. If the RIMM module does not meet these specifications, then the specification can be adjusted by the "Adjusted ∆TPD Specification" table.

Adjusted ∆TPD Specification

Symbol	Parameter and conditions	Adjusted min./max.	Absolute		Unit
			min.	max.	
∆TPD	Propagation delay variation of RSL signals with respect to TPD	+/– [17+(18*N*∆Z0)] *[1]	-30	30	ps

Note: 1 N = Number of RDRAM devices installed on the RIMM module.

∆Z0 = delta Z0% = (max. Z0 - min. Z0) / (min. Z0)

(max. Z0 and min. Z0 are obtained from the loaded (high impedance) impedance coupons of all RSL layers on the module.)

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RIMM Module Current Profile

IDD	RIMM module power conditions *1	Grade	max.	Unit
IDD1	One RDRAM device in Read *2, balance in NAP mode	-AEP, -AE, -AD -8C	688 548	mA
IDD2	One RDRAM device in Read *2, balance in Standby mode	-AEP, -AE, -AD -8C	1290 1010	mA
IDD3	One RDRAM device in Read *2, balance in Active mode	-AEP, -AE, -AD -8C	1570 1220	mA
IDD4	One RDRAM device in Write, balance in NAP mode	-AEP, -AE, -AD -8C	708 558	mA
IDD5	One RDRAM device in Write, balance in Standby mode	-AEP, -AE, -AD -8C	1310 1020	mA
IDD6	One RDRAM device in Write, balance in Active mode	-AEP, -AE, -AD -8C	1590 1230	mA

Notes: 1. Actual power will depend on individual RDRAM component specifications, memory controller and usage patterns. Power does not include Refresh Current.

2. I/O current is a function of the % of 1's, to add I/O power for 50 % 1's for a x18 need to add 276mA for the following: VDD = 2.5V, VTERM = 1.8V, VREF = 1.4V and VDIL = VREF – 0.5V.

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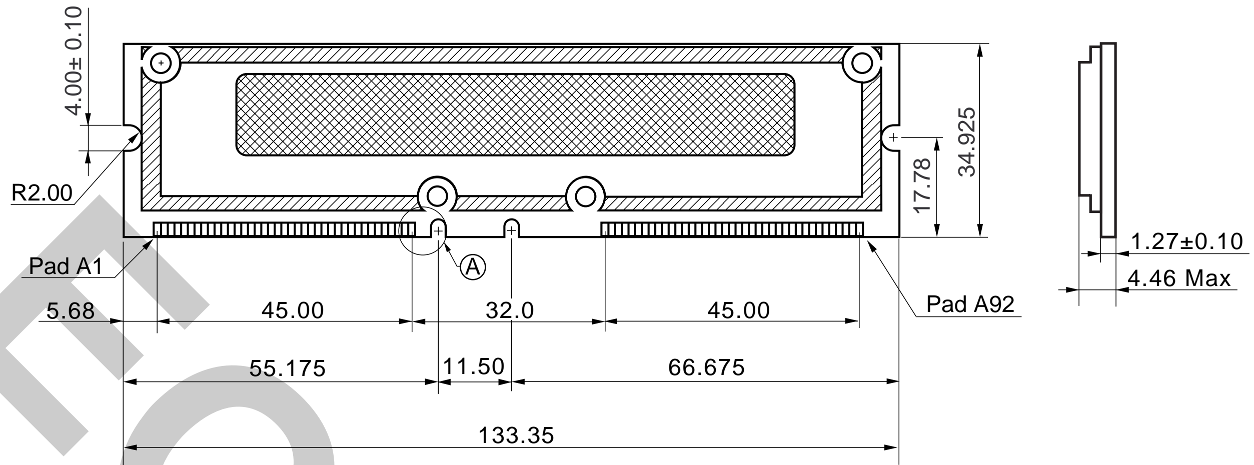
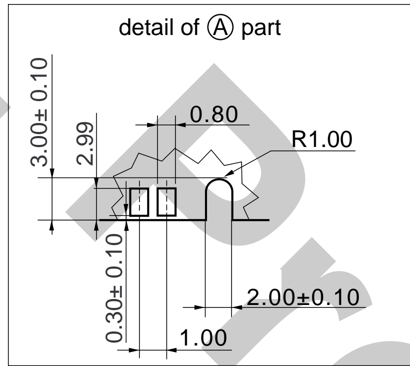
Physical Outline

Unit: mm





Note: The dimensions without tolerance specification use the default tolerance of ± 0.13.

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CAUTION FOR HANDLING MEMORY MODULES

When handling or inserting memory modules, be sure not to touch any components on the modules, such as the memory ICs, chip capacitors and chip resistors. It is necessary to avoid undue mechanical stress on these components to prevent damaging them.
In particular, do not push module cover or drop the modules in order to protect from mechanical defects, which would be electrical defects.

When re-packing memory modules, be sure the modules are not touching each other.
Modules in contact with other modules may cause excessive mechanical stress, which may damage the modules.

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NOTES FOR CMOS DEVICES

① PRECAUTION AGAINST ESD FOR MOS DEVICES

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

② HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to V_{DD} or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.

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